

# ISO 18452:2005-11 (E)

## Fine ceramics (advanced ceramics, advanced technical ceramics) - Determination of thickness of ceramic films by contact-probe profilometer

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<b>Contents</b>		<b>Page</b>
1	Scope .....	1
2	Normative references .....	1
3	Terms and definitions .....	1
4	Principle of measurement .....	1
5	Test environment .....	1
6	Apparatus .....	2
7	Test pieces .....	3
8	Procedure .....	4
9	Calculation .....	5
10	Limits to step height .....	5
11	Test report .....	6